



Detecting stochastic inclusions in electrical impedance tomography

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(joint work with A. Barth, N. Hyvönen and L. Mustonen)

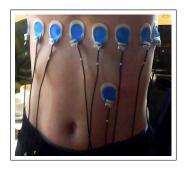
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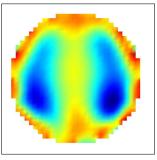
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Electrical impedance tomography (EIT)





- Apply electric currents on subject's boundary
- Measure necessary voltages
- Reconstruct conductivity inside subject.



Mathematical Model (deterministic)

Electrical potential u(x) solves

$$\nabla \cdot (\sigma(x)\nabla u(x)) = 0 \quad x \in D$$

 $D \subset \mathbb{R}^n$: imaged body, $n \ge 2$

 $\sigma(x)$: conductivity

u(x): electrical potential

Idealistic model for boundary measurements (continuum model):

 $\sigma \partial_{\nu} u(x)|_{\partial D}$: applied electric current

 $u(x)|_{\partial D}$: measured boundary voltage (potential)



Calderón problem (deterministic)

Can we recover $\sigma \in L^{\infty}_{+}(D)$ in

$$\nabla \cdot (\sigma \nabla u) = 0, \quad x \in D \tag{1}$$

from all possible Dirichlet and Neumann boundary values

$$\{(u|_{\partial D}, \sigma \partial_{\nu} u|_{\partial D}) : u \text{ solves } (1)\}$$
?

Equivalent: Recover σ from **Neumann-to-Dirichlet-Operator**

$$\Lambda(\sigma): L^2_{\diamond}(\partial D) \to L^2_{\diamond}(\partial D), \quad g \mapsto u|_{\partial D},$$

where u solves (1) with $\sigma \partial_{\nu} u|_{\partial D} = g$.



Inclusion detection in EIT

 σ : Actual (unknown) conductivity

 σ_0 : Initial guess or reference state (e.g. exhaled state)

▶ supp $(\sigma - \sigma_0)$ often relevant in practice

Inclusion detection problem (aka shape reconstruction or anomaly detection)

Can we recover supp
$$(\sigma - \sigma_0)$$
 from $\Lambda(\sigma)$, $\Lambda(\sigma_0)$?

- Generic approach: parametrize supp $(\sigma \sigma_0)$, Level-Set-Methods
- Problems:
 - PDE solutions required in each iteration
 - convergence unclear



Linearization and inclusion detection

Theorem (H./Seo, SIAM J. Math. Anal. 2010)

Let κ , σ , σ_0 pcw. analytic.

$$\Lambda'(\sigma_0)\kappa = \Lambda(\sigma) - \Lambda(\sigma_0) \implies \operatorname{supp}_{\partial D}\kappa = \operatorname{supp}_{\partial D}(\sigma - \sigma_0)$$

 $\operatorname{supp}_{\partial D}$: outer support (= supp + parts unreachable from ∂D)

- → Inclusion detection is essentially a linear problem.
- → Fast, rigorous and globally convergent inclusion detection methods are possible.
 - Next slides: Monotonicity method.



Monotonicity

For two conductivities $\sigma_0, \sigma_1 \in L^{\infty}(\Omega)$:

$$\sigma_0 \le \sigma_1 \implies \Lambda(\sigma_0) \ge \Lambda(\sigma_1)$$

This follows from

$$\int_{\Omega} (\sigma_1 - \sigma_0) |\nabla u_0|^2 \ge \int_{\partial \Omega} g \left(\Lambda(\sigma_0) - \Lambda(\sigma_1) \right) g \ge \int_{\Omega} \frac{\sigma_0}{\sigma_1} (\sigma_1 - \sigma_0) |\nabla u_0|^2$$

for all solutions u_0 of

$$\nabla \cdot (\sigma_0 \nabla u_0) = 0, \quad \sigma_0 \partial_{\nu} u_0|_{\partial \Omega} = g.$$

(e.g., Kang/Seo/Sheen 1997, Ikehata 1998)



Monotonicity based imaging

Monotonicity:

$$\tau \le \sigma \implies \Lambda(\tau) \ge \Lambda(\sigma)$$

- Idea: Simulate $\Lambda(\tau)$ for test cond. τ and compare with $\Lambda(\sigma)$. (Tamburrino/Rubinacci 02, Lionheart, Soleimani, Ventre, ...)
- Inclusion detection: For $\sigma = 1 + \chi_A$ with unknown anomaly A, use $\tau = 1 + \chi_B$, with small ball B.

$$B \subseteq A \implies \tau \le \sigma \implies \Lambda(\tau) \ge \Lambda(\sigma)$$

- ▶ Algorithm: Mark all balls B with $\Lambda(1 + \chi_B) \ge \Lambda(\sigma)$
- Result: upper bound of anomaly A.

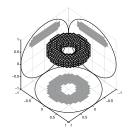
Only an upper bound? Converse monotonicity relation?



Monotonicity method

Theorem (H./*Ullrich*, 2013) $D \setminus \overline{A}$ connected. $\sigma = 1 + \chi_A$.

$$B \subseteq A \iff \Lambda(1 + \chi_B) \ge \Lambda(\sigma).$$



For faster implementation:

$$B \subseteq A \iff \Lambda(1) + \frac{1}{2}\Lambda'(1)\chi_B \ge \Lambda(\sigma).$$

Inclusion can be reconstructed by linearized monotonicity tests.

- → Fast, rigorous, allows globally convergent implementation
- ▶ Ideas of proof evolved from the similar Factorization Method (For EIT: Arridge, Betcke, Brühl, Chaulet, Choi, Hakula, Hanke, H., Holder, Hyvönen, Kirsch, Lechleiter, Nachman, Päivärinta, Pursiainen, Schappel, Schmitt, Seo, Teirilä, . . .)



Calderón problem

Deterministic Calderón Problem: Can we recover σ from NtD

$$\Lambda(\sigma):\ L^2_\diamond(\partial D)\to L^2_\diamond(\partial D),\quad g\mapsto u|_{\partial D},$$

where u solves $\nabla \cdot (\sigma \nabla u) = 0$ with $\sigma \partial_{\nu} u|_{\partial D} = g$?

Stochastic Calderón problem:

Can we recover
$$\mathbb{E}(\sigma)$$
 from $\mathbb{E}(\Lambda(\sigma))$?

- Stochastic inclusion detection in hom. background ($\sigma_0 = 1$):
 - Can we recover $supp(\mathbb{E}(\sigma) 1)$ from $\mathbb{E}(\Lambda(\sigma))$?
- (Possible) Application: Biomedical anomaly detection from temporally averaged measurements.



Detecting stochastic inclusions

Theorem (Barth/H./Hyvönen/Mustonen, submitted)

Consider a domain with with a stochastic inclusion A,

$$\sigma = \begin{cases} 1 & \text{in } D \setminus A, \\ \sigma_A(x, \omega) & \text{in } A, \end{cases}$$

- $\sigma_A : \Omega \to L^{\infty}_+(A)$, Ω probability space,
- $\sigma_A, \sigma_A^{-1} \in L^1(\Omega, L_+^{\infty}(A))$

lf

$$\mathbb{E}(\sigma_A) > 1$$
 and $\mathbb{E}(\sigma_A^{-1})^{-1} > 1$,

then, both, the Factorization Method and the Monotonicity Method applied to $\mathbb{E}(\sigma)$ recover the inclusion A.



Monotonicity for stochastic inclusions

Main idea of the proof: Monotonicity for stochastic inclusions:

For deterministic σ_0 and stochastic σ :

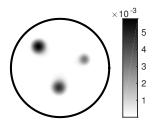
$$\begin{split} \int_D (\mathbb{E}(\sigma) - \sigma_0)) \big| \nabla u_0 \big|^2 \, \, \mathrm{d} x &\geq \int_{\partial D} g \big(\Lambda(\sigma_0) - \mathbb{E}(\Lambda(\sigma)) \big) g \, \, \mathrm{d} s \\ &\geq \int_D \sigma_0^2 \left(\sigma_0^{-1} - \mathbb{E}(\sigma^{-1}) \right) \big| \nabla u_0 \big|^2 \, \, \mathrm{d} x. \end{split}$$

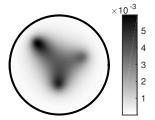
In particular,

$$\sigma_0 \leq \mathbb{E}(\sigma)$$
 and $\sigma_0 \leq \mathbb{E}(\sigma^{-1})^{-1} \implies \Lambda(\sigma_0) \geq \mathbb{E}(\Lambda(\sigma))$



Example





- ▶ Background conductivity $\sigma_0 = 1$
- ▶ Inclusions conductivity uniformly distributed in [0.5, 3.5]

$$\mathbb{E}(\sigma_A) \geq \mathbb{E}(\sigma_A^{-1})^{-1} \approx 1.54 > 1 = \sigma_0$$

Images show result of Factorization Method applied to $\mathbb{E}(\sigma)$ (Left Image: no noise, Right Image: 0.1% noise)



Conclusions

In EIT, stochastic inclusions in a deterministic background

- can be detected by deterministic Factorization or Monotonicity
 Method applied to the measurement's expectation value,
- if, both, $\mathbb{E}(\sigma_A)$ and $\mathbb{E}(\sigma_A^{-1})^{-1}$ are larger than bg conductivity (or both are smaller than background conductivity)

Roughly speaking,

• stochastic conductivity uncertainty in σ is analogous to deterministic uncertainty in $[\mathbb{E}(\sigma^{-1})^{-1}, \mathbb{E}(\sigma)]$

Outlook:

 Stochastic inclusions in stochastic backgrounds may be treatable by resolution guarantees
 (Deterministic case: H., Ullrich, IEEE TMI 2015)